

Enhancement Mode P-Channel Power MOSFET

TO-252/PMOS/-30V/ \pm 20V/-1.6V/-100A/4.3m Ω

Rev_{0.1}





-30V, 4.3mΩ, -100A, Single P-Channel

1.Features

- ◆ -30V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V
- ◆ 100% UIS Tested
- ◆ 100% RG Tested

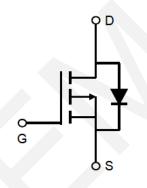
2.Applications

- Power Switching Application
- ◆ Load Switching



Pin Description

V _{DS}	R _{DS(on)} Typ.	I _D Max.	
-30V	4.3mΩ @ -10V	4004	
	6.2mΩ @ -4.5V	-100A	



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP30P100	30P100	TO-252	2,500	25,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{ extsf{DSS}}$	-30	V
Gate to Source Voltage	V _{GSS}	±20	V
Drain Current (DC)	I _D	-100	А
Drain Current (Pulse), PW≤300μs	I _{DP}	-400	А
Total Dissipation	P_{D}	46	W
Avalanche Energy, Single Pulsed	E _{AS}	398	mJ
Junction Temperature	T _j	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to Ambient	$R_{ hetaJA}$	40	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

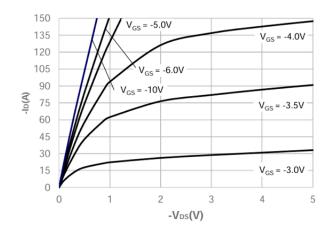
6.Electrical Characteristics at Ta=25°C (Note 3)

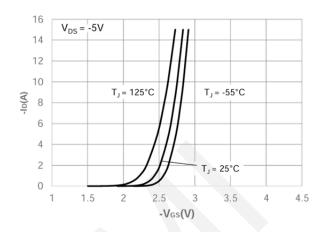
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = -250 \mu A, V_{GS} = 0V$	-30	-	-	٧
Zero-Gate Voltage Drain Current	I _{DSS}	V_{DS} =-30V, V_{GS} = 0V	-	1	-1	μA
Gate to Source Leakage Current	I _{GSS1}	$V_{GS} = \pm 20V$, $V_{DS} = 0V$	ı	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =-250μA	-1.0	-1.6	-2.5	>
Static Drain to Source On-State	0	I _D =-30A, V _{GS} =-10V		4.3	5.5	mΩ
Resistance	$R_{DS(on)}$	I _D =-20A, V _{GS} =-4.5V	-	6.2	8.5	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =-15V,	-	6563	-	pF
Output Capacitance	C_{oss}		-	684	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	1	567	-	pF
Turn-ON Delay Time	t _{d(on)}	V _{DD} = -15V,	ı	12	-	ns
Rise Time	t _r		-	10	-	ns
Turn-OFF Delay Time	$t_{d(off)}$	$V_{GS} = -10V, I_{D} = -30A,$ $R_{GEN} = 3\Omega$	-	88	-	ns
Fall Time	t _f		-	53	-	ns
	Q_g	$V_{DS} = -15V,$ $V_{GS} = 0 \text{ to } -10V,$	-	110	-	nC
Total Gate Charge	Q_{gs}		-	22	-	nC
	Q_{gd}	I _D =-30A	-	21	-	nC
Diode Forward Voltage	V_{FSD}	I _S =-30A, V _{GS} = 0	-	-	-1.2	٧

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

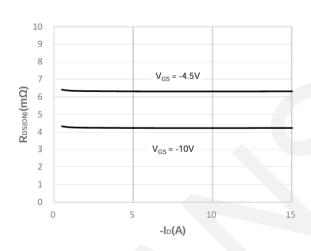


7. Typical electrical and thermal characteristics

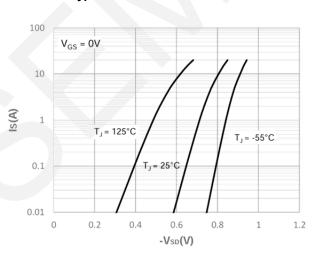




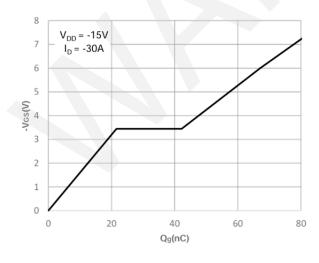
Output Characteristics



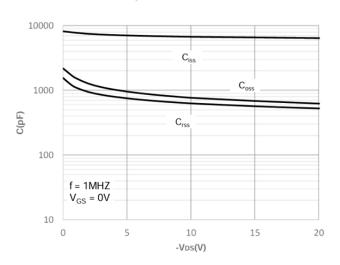
Typical Transfer Characteristics



On-resistance vs. Drain Current



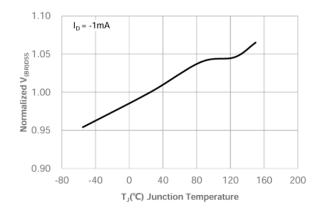
Body Diode Characteristics

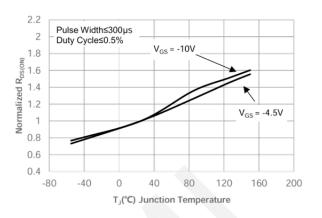


Gate Charge Characteristics

Capacitance Characteristics





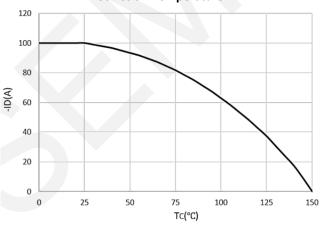


Normalized Breakdown voltage vs. Junction Temperature

1000 Limited by R_{DS(ON)} 100 10us 100us 10 1ms 10ms DC 1 T_C = 25°C Single Puse 0.1 0.1 1 10 100 -V_{DS}(V)

Normalized on Resistance vs.

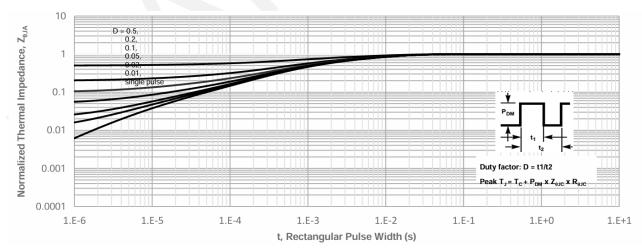




Maximum Safe Operating Area

Maximum Continuous Drain Current vs.

Case Temperature

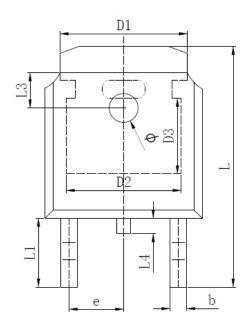


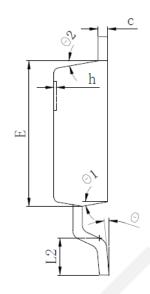
Normalized Maximum Transient

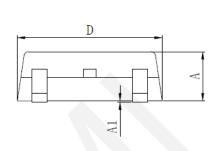
Thermal Impedance



8.Package Dimensions







SYMBOL	MILLIMETER			
	MIN	Тур.	MAX	
A	2. 200	2. 300	2. 400	
A1	0.000		0. 127	
b	0. 640	0.690	0. 740	
c(电镀后)	0. 460	0. 520	0. 580	
D	6. 500	6. 600	6. 700	
D1	5. 334 REF			
D2	4.826 REF			
D3	3.166 REF			
E	6. 000	6. 100	6. 200	
e	2.286 TYP			
h	0.000	0.100	0. 200	
L	9. 900	10. 100	10. 300	
L1	2.888 REF			
L2	1. 400	1.550	1. 700	
L3	1.600 REF			
L4	0.600	0.800	1. 000	
ф	1. 100	1. 200	1. 300	
θ	0°		8°	
θ 1	9° TYP			
θ2		9° TYP		



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